

# **FJN13003**

## **High Voltage Switch Mode Application**

- High Speed Switching
- Suitable for Electronic Ballast up to 21W



## **NPN Silicon Transistor Planar Silicon Transistor**

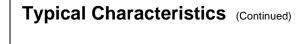
## Absolute Maximum Ratings T<sub>C</sub>=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector-Base Voltage	700	V
$V_{CEO}$	Collector-Emitter Voltage	400	V
V <sub>EBO</sub>	Emitter-Base Voltage	9	V
I <sub>C</sub>	Collector Current (DC)	1.5	A
I <sub>CP</sub>	*Collector Current (Pulse)	3	А
I <sub>B</sub>	Base Current (DC)	0.75	А
I <sub>BP</sub>	*Base Current (Pulse)	1.5	А
P <sub>C</sub>	Collector Power Dissipation(T <sub>a</sub> =25°C)	1.1	W
T <sub>J</sub>	Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature	- 65 ~ 150	°C

<sup>\*</sup> Pulse Test: Pulse Width=5ms, Duty Cycle ≤ 10%

## **Electrical Characteristics** $T_a$ =25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	I <sub>C</sub> =500μA, I <sub>E</sub> =0	700			V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage	$I_C=5$ mA, $I_B=0$	400			V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	I <sub>E</sub> =500μA, I <sub>C</sub> =0	9			V
I <sub>EBO</sub>	Emitter Cut-off Current	V <sub>EB</sub> =9V, I <sub>C</sub> =0			10	μΑ
h <sub>FE</sub>	DC Current Gain	V <sub>CE</sub> =2V, I <sub>C</sub> =0.5A	9		21	
		V <sub>CE</sub> =2V, I <sub>C</sub> =1.0A	5			
V <sub>CE</sub> (sat)	Collector-Emitter Saturation Voltage	I <sub>C</sub> =0.5A, I <sub>B</sub> =0.1A			0.5	V
		I <sub>C</sub> =1.0A, I <sub>B</sub> =0.25A			1.0	V
		I <sub>C</sub> =1.5A, I <sub>B</sub> =0.5A			3.0	V
V <sub>BE</sub> (sat)	Base-Emitter Saturation Voltage	I <sub>C</sub> =0.5A, I <sub>B</sub> =0.1A			1.0	V
		I <sub>C</sub> =1.0A, I <sub>B</sub> =0.25A			1.2	V
f <sub>T</sub>	Current Gain Bandwidth Product	V <sub>CE</sub> =10V, I <sub>C</sub> =0.1A	4			MHz
t <sub>ON</sub>	Turn ON Time	V <sub>CC</sub> =125V, I <sub>C</sub> =1A,			1.1	μs
t <sub>STG</sub>	Storage Time	I <sub>B1</sub> =0.2A, I <sub>B2</sub> =-0.2A,			4.0	μs
t <sub>F</sub>	Fall Time	$R_L = 125\Omega$			0.7	μs



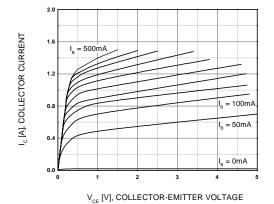


Figure 1. Static Characteristic

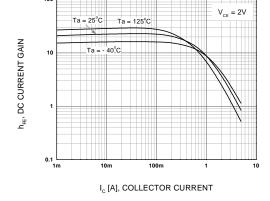


Figure 2. DC current Gain

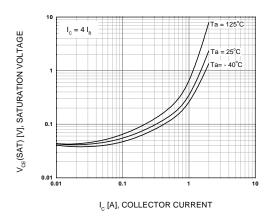


Figure 3. Collector-Emitter Saturation Voltage

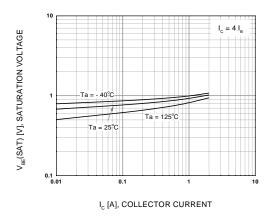


Figure 4. Base-Emitter Saturation Voltage

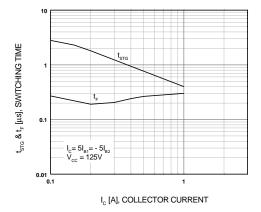


Figure 5. Resistive Load Switching Time

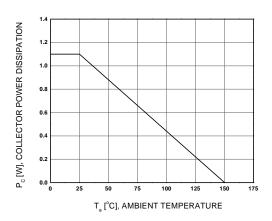
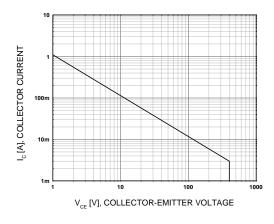


Figure 6. Power Derating

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# **Typical Characteristics**

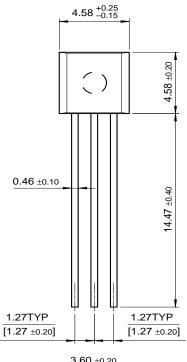


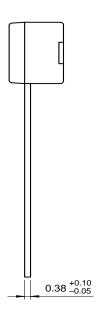
1.4 | R<sub>82</sub> = 0, I<sub>81</sub> = 1A | V<sub>CC</sub> = 10V, L = 50mH | N<sub>CC</sub> = 10V, L = 10V, N<sub>CC</sub> = 10V, L = 10V, N<sub>CC</sub> = 10V, N<sub>CC</sub> = 10V, L = 10V, N<sub>CC</sub> = 10V, N

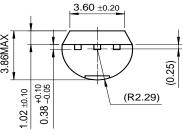
Figure 7. Forward Bias Safe Operating Area

Figure 8. Reverse Bias Safe Operating Area

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